

Form PTO-1449		ATTY. DOCKET NO. 0051-0212P	APPLICATION NO. 10/662,355				
INFORMATION DISCLOSURE CITATION IN AN APPLICATION <i>O I P E S C I T A T I O N</i> Use several sheets if necessary) MAR 09 2004		APPLICANT Atsushi MIYAWAKI et al.					
		FILING DATE September 16, 2003	GROUP				
U.S. PATENT DOCUMENTS							
EXAMINER INITIALS	DOCUMENT NUMBER	KIND	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	US						
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FOREIGN PATENT DOCUMENTS				COUNTRY	CLASS	SUB CLASS	TRANSLATION
<i>ptv</i>	Office DE	DOCUMENT NUMBER 44 36 500	KIND A	DATE 1995-05-11	GERMANY	—	— X
OTHER DOCUMENTS (Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.)							
<i>ptv</i>	Proll K-P et al.: "Application of a Liquid-Crystal Spatial Light Modulator for Brightness Adaptation in Microscopic Topometry," Applied Optics, Optical Society of America, vol. 39, no. 34, Dec. 1, 2000, pgs 6430-6435						
EXAMINER <i>Phoebe</i>				DATE CONSIDERED <i>12/18/06</i>			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION <small>(Use several sheets if necessary)</small>		APPLICANT Atsushi MIYAWAKI et al.						
		FILING DATE September 16, 2003		GROUP 2621				
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL	DOCUMENT NUMBER	Kind	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	US							
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FOREIGN PATENT DOCUMENTS								
Office	DOCUMENT NUMBER	Kind	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION	
JP	11-83454	(A)	1999-03-26	JAPAN	—	—	YES	NO
*JP	2002-500369	(A)	2002-01-08	JAPAN	—	—	ABS	
*WO	99/34301	A1	1999-07-08	PCT	—	—		
OTHER DOCUMENTS (Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.)								
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* Please note that WO 99/34301 corresponds to JP 2002-500369.

JMS/apw



PTO/SB/08a/b (07-05)

Approved for use through 07/31/2006. OMB 0651-0031

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Substitute for form 1449A/B/PTO				Complete If Known	
				Application Number	10/662,355-Conf. #2060
				Filing Date	September 16, 2003
				First Named Inventor	Atsushi MIYAWAKI
				Art Unit	2624
				Examiner Name	J. Wu
Sheet	1	of	1	Attorney Docket Number	0051-0212P

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
PT	BA	WO-02/12945-A2	02-14-2002	Carl Zeiss Jena GmbH	<input checked="" type="checkbox"/>

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Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			

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¹Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	<i>Phamstram</i>	Date Considered	12/18/06
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